International Rectifier

IRL2703PbF

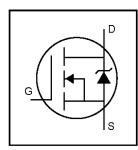
HEXFET® Power MOSFET

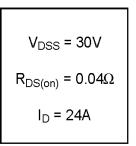
- Logic-Level Gate Drive
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

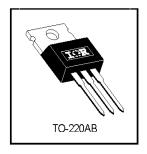
Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.







Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	24	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	17	A
I _{DM}	Pulsed Drain Current ①	96	
P _D @T _C = 25°C	Power Dissipation	45	W
	Linear Derating Factor	0.30	W/°C
V _{GS}	Gate-to-Source Voltage	±16	V
E _{AS}	Single Pulse Avalanche Energy ②	77	mJ
I _{AR}	Avalanche Current®	14	Α
E _{AR}	Repetitive Avalanche Energy①	4.5	mJ
d∨/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range) ℃
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
R _{BJC}	Junction-to-Case			3.3	
R _{OCS}	Case-to-Sink, Flat, Greased Surface		0.50		°C/W
Reja	Junction-to-Ambient			62	Ī

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	30			٧	$V_{GS} = 0V$, $I_D = 250\mu A$
ΔV _{(BR)DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient		0.030		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.040	Ω	V _{GS} = 10V, I _D = 14A ④
				0.060	1 22	V _{GS} = 4.5V, I _D = 12A ④
V _{GS(th)}	Gate Threshold Voltage	1.0			V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
g fs	Forward Transconductance	6.4			S	$V_{DS} = 25V, I_{D} = 14A$
I _{DSS}	Drain-to-Source Leakage Current			25	μA	$V_{DS} = 30V, V_{GS} = 0V$
1055	Brain to course Ecanage Carrent			250	μΛ	V _{DS} = 24V, V _{GS} = 0V, T _J = 150°C
1	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	IIA	V _{GS} = -16V
Qg	Total Gate Charge			15		I _D = 14A
Q _{gs}	Gate-to-Source Charge			4.6	nC	V _{DS} = 24V
Q _{gd}	Gate-to-Drain ("Miller") Charge			9.3		V _{GS} = 4.5V, See Fig. 6 and 13
t _{d(on)}	Turn-On Delay Time		8.5			V _{DD} = 15V
tr	Rise Time		140		ns	I _D = 14A
t _{d(off)}	Turn-Off Delay Time		12		115	$R_G = 12\Omega$, $V_{GS} = 4.5V$
t _f	Fall Time		20			R_D = 1.0Ω, See Fig. 10 ④
	Internal Drain Inductance	_	4.5	-		Between lead,
L _D						6mm (0.25in.)
L _S	Internal Source Inductance		7.5	_	nΗ	from package
						and center of die contact
C _{iss}	Input Capacitance		450			$V_{GS} = 0V$
Coss	Output Capacitance		210		pF	V _{DS} = 25V
Crss	Reverse Transfer Capacitance		110			f = 1.0MHz, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions		
Is	Continuous Source Current		24		MOSFET symbol			
	(Body Diode)			24	A	showing the		
Ism	Pulsed Source Current	1	<u> </u>	96	— 96		integral reverse	
	(Body Diode) ①							•
V _{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C, I _S = 14A, V _{GS} = 0V		
t _{rr}	Reverse Recovery Time		65	97	ns	T _J = 25°C, I _F = 14A		
Qrr	Reverse RecoveryCharge	T	140	210	nC	di/dt = 100A/µs ⊕		
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)						

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② V_{DD} = 15V, starting T_J = 25°C, L = 570 μ H R_G = 25 Ω , I_{AS} = 14A. (See Figure 12)
- $\label{eq:loss_def} \begin{tabular}{ll} \begin{tabular}{ll} $I_{SD} \leq 144A, \ di/dt \leq 140A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \\ $T_{J} \leq 175^{\circ}C$ \end{tabular}$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.

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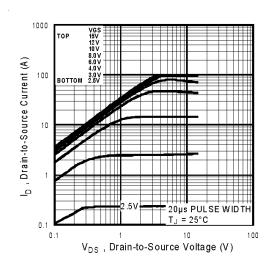


Fig 1. Typical Output Characteristics

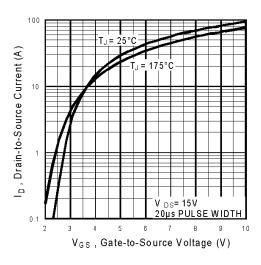


Fig 3. Typical Transfer Characteristics

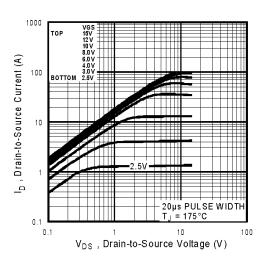


Fig 2. Typical Output Characteristics

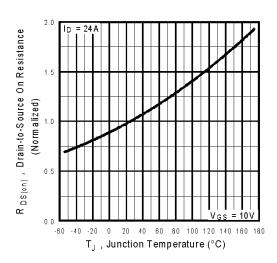


Fig 4. Normalized On-Resistance Vs. Temperature

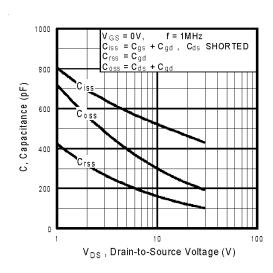


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

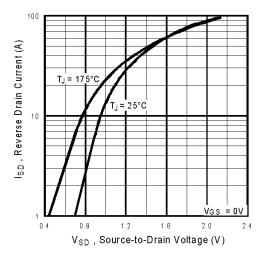


Fig 7. Typical Source-Drain Diode Forward Voltage

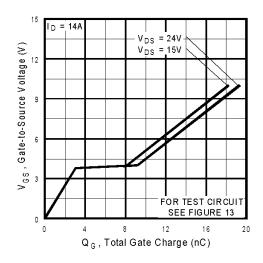


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

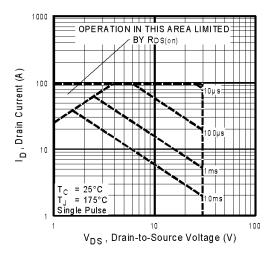


Fig 8. Maximum Safe Operating Area

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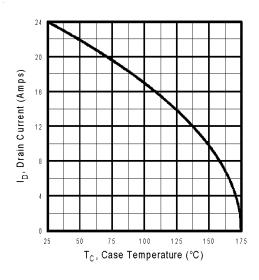


Fig 9. Maximum Drain Current Vs. Case Temperature

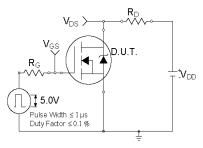


Fig 10a. Switching Time Test Circuit

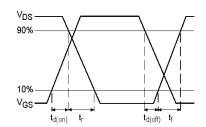


Fig 10b. Switching Time Waveforms

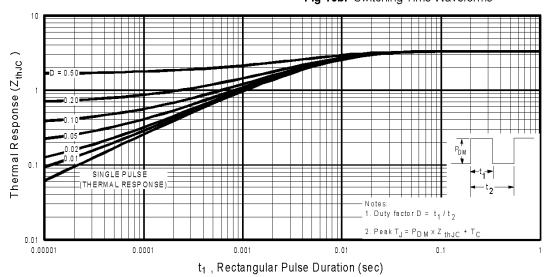


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

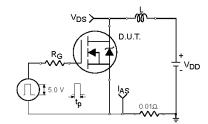


Fig 12a. Unclamped Inductive Test Circuit

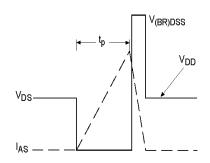


Fig 12b. Unclamped Inductive Waveforms

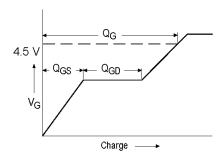


Fig 13a. Basic Gate Charge Waveform

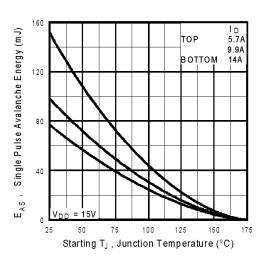


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

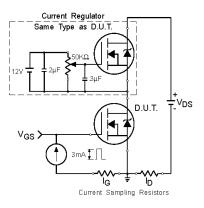
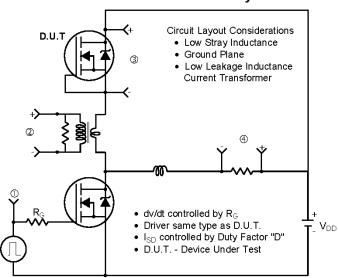


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



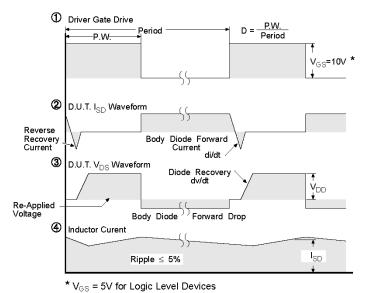
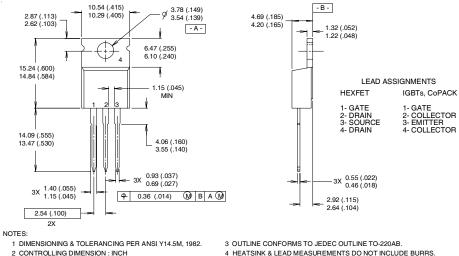


Fig 14. For N-Channel HEXFETS

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



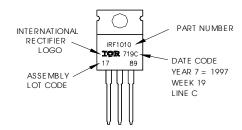
- 2 CONTROLLING DIMENSION: INCH
- TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789

ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free'



Data and specifications subject to change without notice.



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